

JUN 0 4 2004 CC

HIT 906-07

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

T. FURUHASHI et al

Serial No. 10/633,512

Group Art Unit: 2674

Filed: August 5, 2003

Examiner: X. Wu

For: LIQUID CRYSTAL DISPLAY CONTROL DEVICE

UNDER § 1.97 AND § 1.98

Commissioner for Patents Mail Stop DD P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

1. This IDS should be considered:

- (a) when filed within three months of the filing date of the present application, or within three months of the filing date of the National Stage as set forth in § 1.491 in an international application, or before the mailing date of a first Office Action on the merits, whichever occurs last;
- (b) when filed before the mailing date of either a Final Rejection under § 1.113 or a Notice of Allowance under § 1.311, whichever occurs first and when 1(a) does not apply. For this purpose, there is included herein either a certification in section 4 below (included when indicated by a marked box), or a fee of \$180.00 (a Credit Card Payment Form in the amount of \$180.00 is enclosed, or if not see section 5 below);
- (c) when filed prior to the payment of the Issue Fee, when 1(a)-(b) do not apply, and when a certification is included in section 4 below (included when indicated by a marked box); then the Applicant(s) hereby petition(s) and request(s) consideration of this IDS, and provided herewith is

a fee of \$180.00 (a Credit Card Payment Form in the amount of \$180.00 to cover the petition fee, or if not see section 5 below).

- 2. When 1(a)-(c) do not apply, then it is requested that this IDS be placed in the file.
- 3. Listing of the information submitted is on the attached Form PTO-1449, which forms a part of this IDS. A copy of each listed document is enclosed.
- If a fee or additional fee is required, the Commissioner is hereby authorized to charge any fee or additional fee that may be required and credit any excess to Deposit Account No. 50-1417.
- No explanation of relevancy is being provided for the documents because each is either in the English language or has an English-language Abstract.
- If the PTO determines that part(s) of the required content is inadvertently omitted, then it is requested that the Applicant(s) be given additional time and specific identification of such omission(s) to enable full compliance.

Respectfully submitted,

Daniel f. Stanger Registration No. 32,846 Attorney for Applicants

MATTINGLY, STANGER & MALUR 1800 Diagonal Rd., Suite 370 Alexandria, Virginia 22314 (703) 684-1120

Date: June 4, 2004

Sheet 1 of 3

FORM PTO-1449 (REV. 7-80)

EXAMINER

S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. ATENT AND TRADEMARK OFFICE HIT 906-07

LIST OF DOCUMENTS CITED BY APPLICANT

(Use several sheets if necessary)

SERIAL NO. 10/633,512

APPLICANT

T. FURUHASHI et al

FILING DATE August 5, 2003 GROUP 2674

U.S. PATENT DOCUMENTS

				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate
	AA	6,067,071	05/23/00	Kotha et al			
	AB	5,739,867	04/14/98	Eglit			
	AC	5,534,934	07/09/96	Katsumata et al			
	AD	5,532,716	07/02/96	Sano			
	ΑE	5,528,305	06/18/96	Kim			
•	AF	5,469,223	11/21/95	Kimura			
	AG	5,874,937	02/23/99	Kesatoshi			
	АН	4,771,279	09/13/88	Hannah	-		
	AI	5,016,193	05/14/91	Stone et al			
	AJ	5,742,261	04/21/98	Yuki et al			
	AK	4,935,731	06/19/90	Takebe et al			
				FOREIGN PATENT DOCUMENTS			
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	7-49662	02/21/95	Japan (w/ English Abstract)			
	АМ	5-323899	12/07/93	Japan (w/ English Abstract)			
	AN	2-9277	01/12/90	Japan (w/ English Abstract)			
	ΑО	1-194784	08/04/89	Japan (w/ English Abstract)			
	AP	5-119749	05/18/93	Japan (w/ English Abstract)			
		•	OTHER DOCU	MENTS (Including Author, Title, Date, Pertinent P	ages, etc.)		
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^{*} EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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AO 2-1889 01/08/90 Japan (w/ English Abstract)		АМ			11/19/92	Japan (w/ Eng	glish Abstract)					
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	АМ	7-19	99855	08/04/	95	Japan (w/ E	nglish	Abstract)						
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